Unit in mm

TOSHIBA Photocoupler GaAlAs IRed & Photo-Triac

# **TLP168J**

Triac Drive
Programmable Controllers
AC-Output Module
Solid State Relay

The TOSHIBA mini flat coupler TLP168J is a small outline coupler, suitable for surface mount assembly.

The TLP168J consists of a photo triac, optically coupled to a GaAlAs infrared emitting diode.

• Zero-voltage crossing turn-on

Peak off-state voltage: 600 V (min.)
Trigger LED current: 3 mA (max.)

On-state current: 70 mA (max.)
Isolation voltage: 2500 Vrms (min.)

#### Absolute Maximum Ratings (Ta = 25°C)

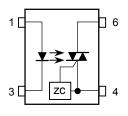
Characteristic			Symbol	Rating	Unit	
	Forward current		ΙF	20	mA	
TED	Forward current derating (Ta ≥ 25°C)		ΔI <sub>F</sub> / °C	-0.2	mA / °C	
	Peak forward current (100µs pulse, 100 pps)		I <sub>FP</sub>	1	А	
	Reverse voltage		V <sub>R</sub>	5	V	
	Junction temperature		Tj	125	°C	
	Off– state output terminal voltage		$V_{DRM}$	600	٧	
	On-state RMS current	Ta=25°C	I	70	mΛ	
Detector		Ta=70°C	I <sub>T(RMS)</sub>	40	mA	
	On–state current derating (Ta ≥ 25°C)		ΔI <sub>T</sub> / °C	-0.67	mA / °C	
	Peak on–state current (100µs pulse, 120 pps)		I <sub>TP</sub>	2	А	
	Peak nonrepetitive surge current (PW=10ms, DC=10%)		I <sub>TSM</sub>	1.2	Α	
	Junction temperature		Tj	115	°C	
Stora	Storage temperature range		T <sub>stg</sub>	-55~125	°C	
Oper	Operating temperature range		T <sub>opr</sub>	-40~100	°C	
Lead	ad soldering temperature (10s)		T <sub>sol</sub>	260	°C	
	Isolation voltage (AC, 1 min., R.H. ≤ 60%) (Note)			2500	Vrms	

60.2

TOSHIBA 11-4C3

Weight: 0.09 g

# **Pin Configurations**



1: Anode

3: Cathode

4: Terminal 1

6: Terminal 2

Note:

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

(Note) Device considered a two terminal device: Pins 1 and 3 shorted together and pins 4 and 6 shorted together.



# **Recommended Operating Conditions**

Characteristic	Symbol	Min.	Тур.	Max.	Unit
Supply voltage	V <sub>AC</sub>	_	_	240	V <sub>ac</sub>
Forward current	lF	4.5	6	7.5	mA
Peak on-state current	I <sub>TP</sub>	_	_	1	Α
Operating temperature	T <sub>opr</sub>	-10	_	85	°C

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

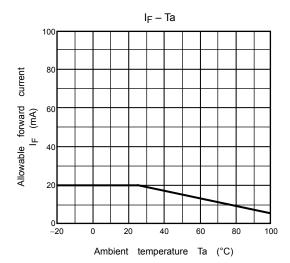
# **Individual Electrical Characteristics (Ta = 25°C)**

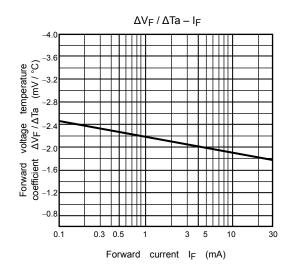
Characteristic		Symbol	Test Condition	Min.	Тур.	Max.	Unit
LED	Forward voltage	V <sub>F</sub>	I <sub>F</sub> =10mA	1.2	1.4	1.7	V
	Reverse current	I <sub>R</sub>	V <sub>R</sub> =3V	_	_	10	μΑ
	Capacitance	C <sub>T</sub>	V=0, f=1MHz	_	30	_	pF
Detector	Peak off-state current	I <sub>DRM</sub>	V <sub>DRM</sub> =600V	_	10	1000	nA
	Peak on-state voltage	V <sub>TM</sub>	I <sub>TM</sub> =70mA	_	1.7	2.8	٧
	Holding current	lΗ	_	_	0.6	_	mA
	Critical rate of rise of off– state voltage	dv / dt	V <sub>in</sub> =240Vrms, Ta=85°C	200	500	_	V / µs
	Critical rate of rise of commutating voltage	dv / dt(c)	V <sub>in</sub> =60Vrms I <sub>T</sub> =15mArms	_	0.2	_	V / µs

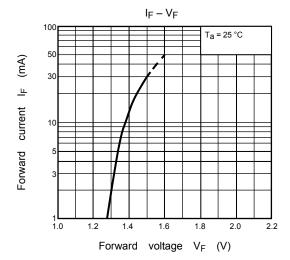
#### **Coupled Electrical Characteristics (Ta = 25°C)**

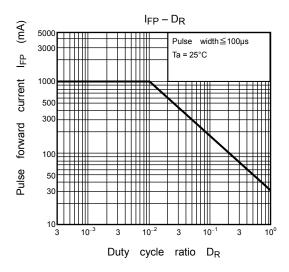
Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit	
Trigger LED current	I <sub>FT</sub>	V <sub>T</sub> =6V	_	_	3	mA	
Inhibit voltage	V <sub>IH</sub>	I <sub>F</sub> =Rated I <sub>F</sub> T	_	_	50	V	
Leakage in inhibited state	lіН	I <sub>F</sub> =Rated I <sub>FT</sub> V <sub>T</sub> = Rated V <sub>DRM</sub>	_	200	600	μΑ	
Capacitance (input to output)	Cs	V <sub>S</sub> =0, f=1MHz	_	0.8	_	pF	
Isolation resistance	R <sub>S</sub>	V <sub>S</sub> =500V, R.H. ≤ 60%	5×10 <sup>10</sup>	10 <sup>14</sup>	_	Ω	
	BVS	AC, 1 minute	2500	_	_	Vrms	
Isolation voltage		AC, 1 second, in oil	_	5000	_	VIIIIS	
		DC, 1 minute, in oil	_	5000	_	Vdc	

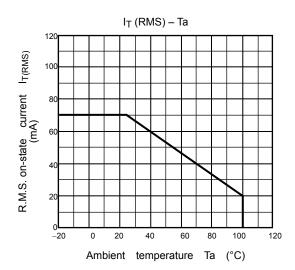
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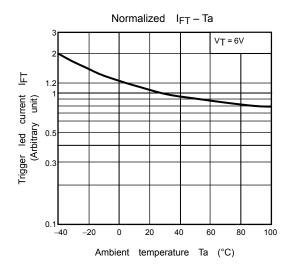


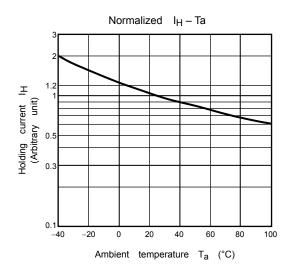


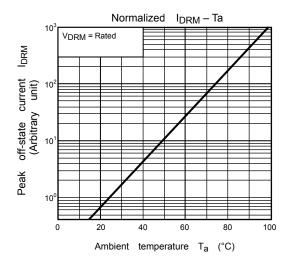


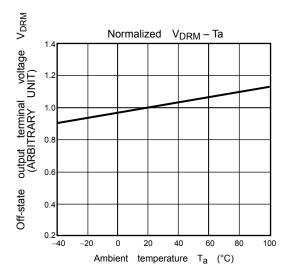


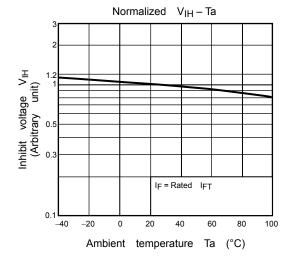


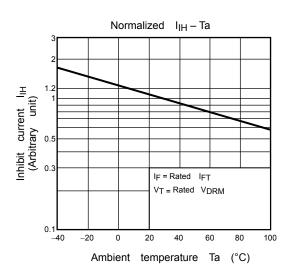












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